Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination MIYAUCHI, TSUTOMU	
10/520,427		
Examiner	Art Unit	

Than Nguyen

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	SEARCHED						
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
711	159,160	5/16/2007	NTV		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST IEEE Inventor	5/16/2007	NTV		